

<b>Notice of References Cited</b>	Application/Control No. 10/575,954	Applicant(s)/Patent Under Reexamination SHIN, KAP SOO	
	Examiner JASON HECKERT	Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0101774	05-2007	Lee, Kyu Hwan	068/208
*	B	US-2004/0154348	08-2004	Kim et al.	068/012.01
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

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